

General Description

The Sanrise SRC60R068BS is a high voltage power MOSFET, fabricated using advanced super junction technology. The resulting device has extremely low on resistance, low gate charge and fast switching time, making it especially suitable for applications which require superior power density and outstanding efficiency.

The SRC60R068BS break down voltage is 600V and it has a high rugged avalanche characteristics. The SRC60R068BS is available in TO-247, TO-263-2, TO-220C and TO-220F packages.

Features

- Ultra Low $R_{DS(ON)} = 68m\Omega @ V_{GS} = 10V$.
- Ultra Low Gate Charge, $Q_g = 110nC$ typ.
- Fast switching capability
- Robust design with better EAS performance
- EMI Improved
- Non-automotive Qualified

Application

- Telecom Power
- EV Charger
- High Power Application

Symbol

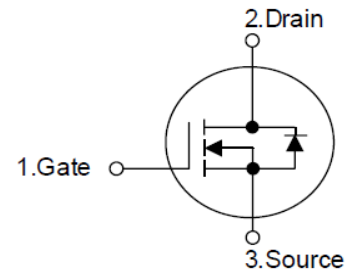


Figure 1 Symbol of SRC60R068BS

Package Type

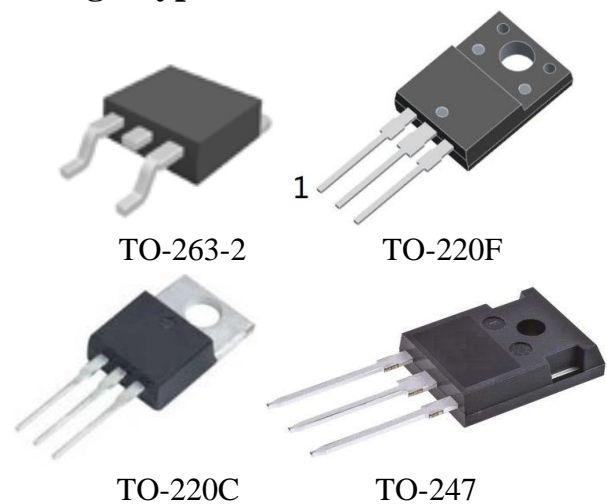
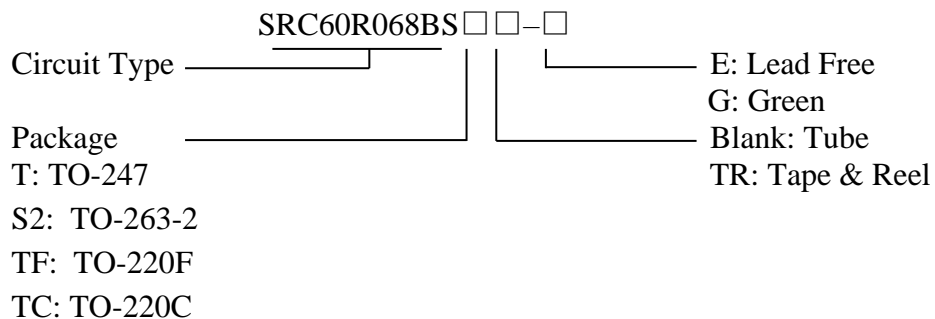


Figure 2 Package Types of SRC60R068BS

Ordering Information



Package	Part Number		Marking ID		Packing Type
	Lead Free	Green	Lead Free	Green	
TO-247	SRC60R068BST-E	SRC60R068BST-G	SRC60R068BSTE	SRC60R068BSTG	Tube
TO-263-2	SRC60R068BSS2TR-E	SRC60R068BSS2TR-G	SRC60R068BSS2E	SRC60R068BSS2G	Tape & Reel
TO-220F	SRC60R068BSTF-E	SRC60R068BSTF-G	SRC60R068BSTFE	SRC60R068BSTFG	Tube
TO-220C	SRC60R068BSSTC-E	SRC60R068BSSTC-G	SRC60R068BSTCE	SRC60R068BSTCG	Tube

Absolute Maximum Ratings

Parameter		Symbol	Rating	Unit
Drain-Source Voltage		V_{DSS}	600	V
Gate-Source Voltage		V_{GSS}	±30	V
Continuous Drain Current	$T_C=25^{\circ}C$	I_D	48	A
	$T_C=125^{\circ}C$		21.5	
Pulsed Drain Current (Note 2)		I_{DM}	144	A
Avalanche Energy, Single Pulse (Note 3)		E_{AS}	610	mJ
Avalanche Energy, Repetitive (Note 2)		E_{AR}	0.6	mJ
Avalanche Current, Repetitive (Note 2)		I_{AR}	4.8	A
Continuous Diode Forward Current		I_S	48	A
Diode Pulse Current		$I_{S,PULSE}$	144	A
MOSFET dv/dt Ruggedness, $V_{DS} \leq 480V$		dv/dt	50	V/ns
Reverse Diode dv/dt, $V_{DS} \leq 480V, I_{SD} = I_D$		dv/dt	50	V/ns
Power Dissipation (TO-247)		P_D	357	W
ESD		HBM	>1000	V
Operating Junction Temperature		T_J	150	°C
Storage Temperature		T_{STG}	-55 to 150	°C
Lead Temperature (Soldering, 10 sec)		T_{LEAD}	260	°C

Note:

1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.
2. Repetitive Rating: Pulse width limited by maximum junction temperature
3. $I_{AS} = 4.8A, V_{DD} = 60V, R_G = 25\Omega, \text{Starting } T_J = 25^{\circ}C$

Thermal characteristics

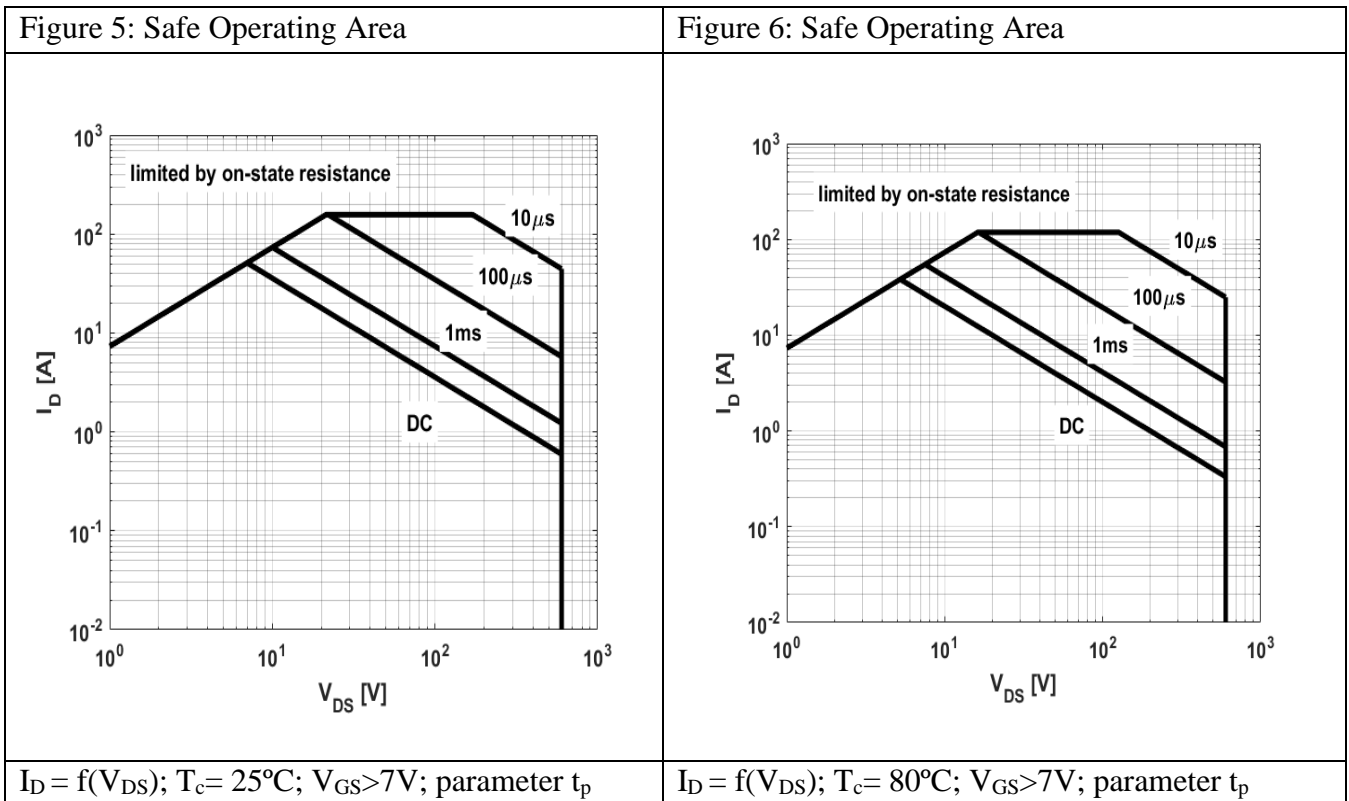
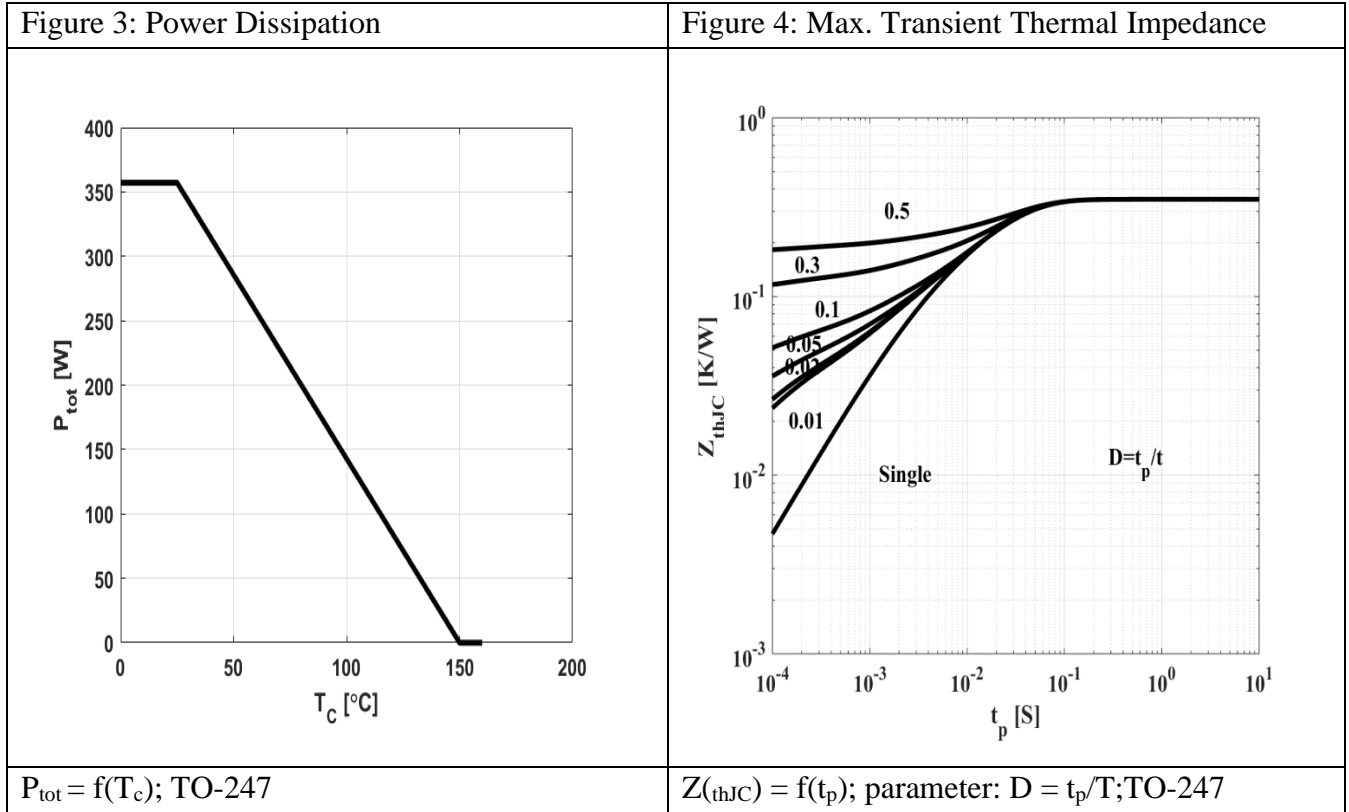
Parameter		Symbol	Min	Typ	Max	Unit
Thermal resistance, Junction-to-Case	TO-220F	R_{thJC}			3.5	°C /W
	TO-220C				0.35	
	TO-247				0.35	
	TO-263				0.35	
Thermal resistance, Junction-to-Ambient	TO-220F	R_{thJA}			70	°C /W
	TO-220C				58	
	TO-247				58	
	TO-263				58	

Electrical Characteristics
 $T_J = 25^{\circ}\text{C}$, unless otherwise specified.

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Statistic Characteristics						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS}=0V, I_D=250\mu A$	600			V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS}=600V, V_{GS}=0V$			10	μA
Gate-Body Leakage Current	Forward	$I_{GSSF}, V_{GS}=30V, V_{DS}=0V$			100	nA
	Reverse	$I_{GSSR}, V_{GS}=-30V, V_{DS}=0V$			-100	
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{DS}=V_{GS}, I_D=1.0mA$	3.0	4.0	5.0	V
Static Drain-Source On-Resistance	$R_{DS(ON)}$	$V_{GS}=10V, I_D=24A$		57	68	mΩ
Gate Resistance	R_G	f=1MHz, Open Drain		1.0		Ω
Dynamic Characteristics						
Input Capacitance	C_{ISS}	$V_{DS}=50V, V_{GS}=0V,$ f=1MHz		4.3		nF
Output Capacitance	C_{OSS}			171		pF
Reverse Transfer Capacitance	C_{RSS}			2.8		pF
Effective output capacitance, energy related ^{NOTE5}	$C_{O(er)}$	$V_{GS}=0V,$ $V_{DS}=0\dots 400V$		94		pF
Effective output capacitance, time related ^{NOTE6}	$C_{O(tr)}$			550		
Turn-on Delay Time	$t_{d(on)}$	$V_{DD}=400V, I_D=24A$ $R_G=3.3\Omega, V_{GS}=10V$		16		ns
Rise Time	t_r			6.0		
Turn-off Delay Time	$t_{d(off)}$			98		
Fall Time	t_f			4.0		
Gate Charge Characteristics						
Gate to Source Charge	Q_{gs}	$V_{DD}=480V, I_D=24A$ $V_{GS}=0$ to 10V		28.1		nC
Gate to Drain Charge	Q_{gd}			56.0		
Gate Charge Total	Q_g			110		
Gate Plateau Voltage	$V_{plateau}$			6.5		V
Reverse Diode Characteristics						
Drain-Source Diode Forward Voltage	V_{SD}	$V_{GS}=0V, I_{SD}=24A$		0.9	1.1	V
Reverse Recovery Time	t_{rr}	$V_R=400V, I_F=24A$ dI _F /dt=100A/us		141		ns
Reverse Recovery Charge	Q_{rr}			0.83		μC
Peak Reverse Recovery Current	I_{rrm}			11.8		A

Note:

- $C_{O(er)}$ is a fixed capacitance that gives the same stored energy as C_{OSS} while V_{DS} is rising from 0 to 480V
- $C_{O(tr)}$ is a fixed capacitance that gives the same charging time as C_{OSS} while V_{DS} is rising from 0 to 480 V

Typical Performance Characteristics


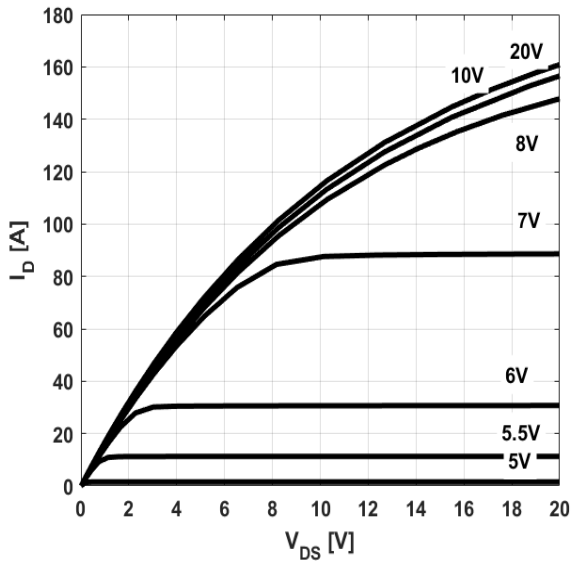
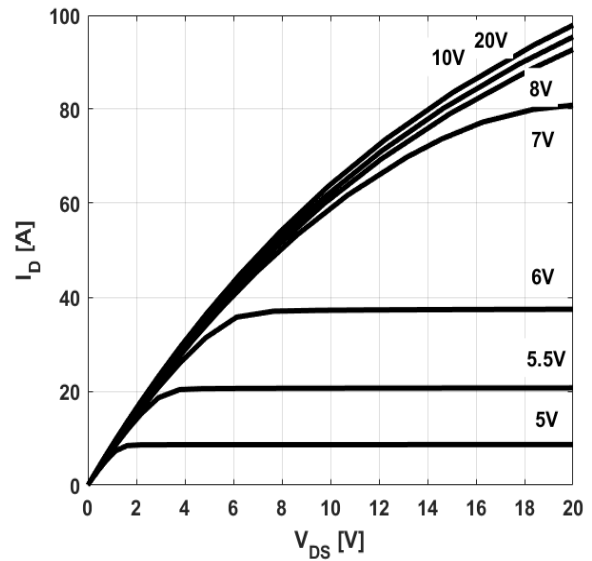
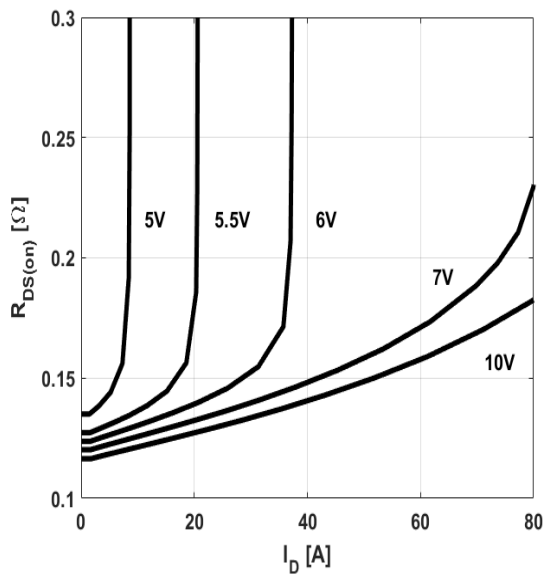
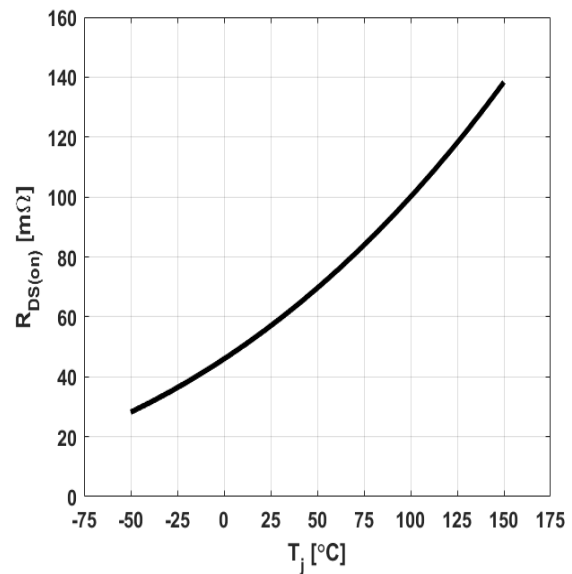
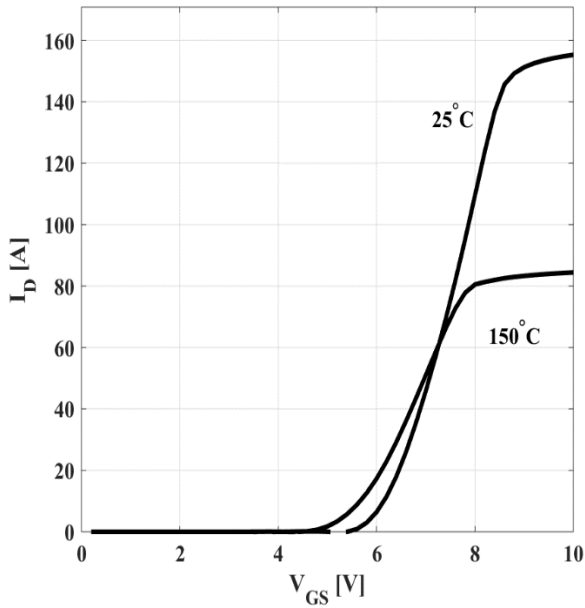
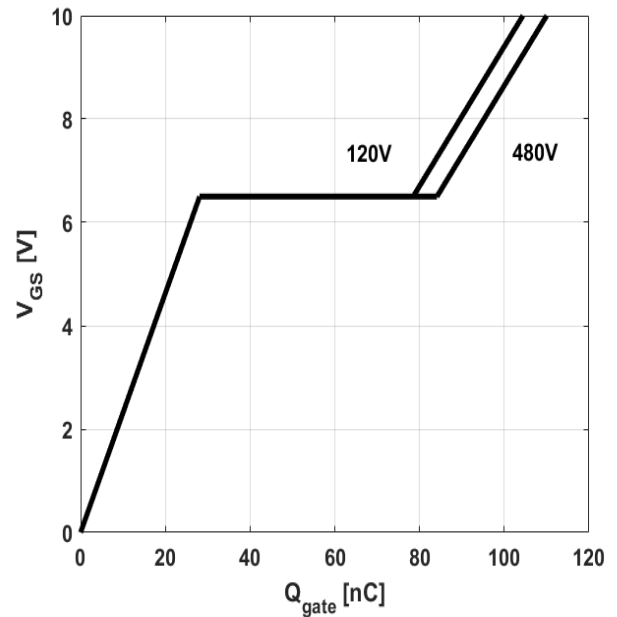
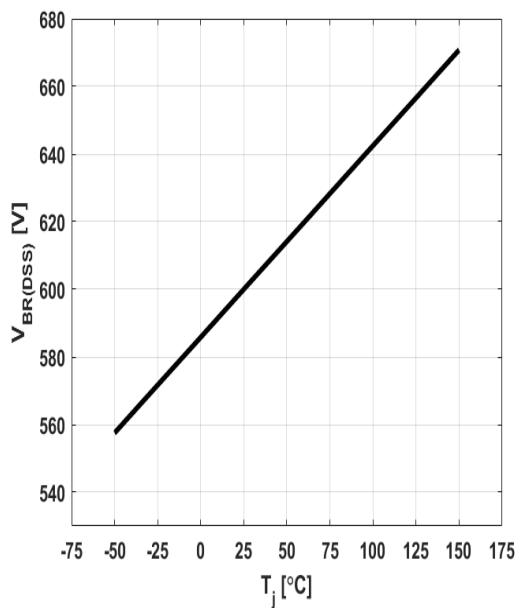
68mΩ, 600V, Super Junction N-Channel Power MOSFET
SRC60R068BS
Figure 7: Typ. Output Characteristics

 $I_D = f(V_{DS}); T_j = 25^\circ\text{C}; \text{parameter: } V_{GS}$
Figure 8: Typ. Output Characteristics

 $I_D = f(V_{DS}); T_j = 125^\circ\text{C}; \text{parameter: } V_{GS}$
Figure 9: Typ. Drain-Source On-State Resistance

 $R_{DS(ON)} = f(I_D); T_j = 125^\circ\text{C}; \text{parameter: } V_{GS}$
Figure 10: Typ. Drain-Source On-State Resistance

 $R_{DS(ON)} = f(T_j); I_D = 24\text{A}; V_{GS} = 10\text{V}$

Figure 11: Typ. Transfer Characteristics


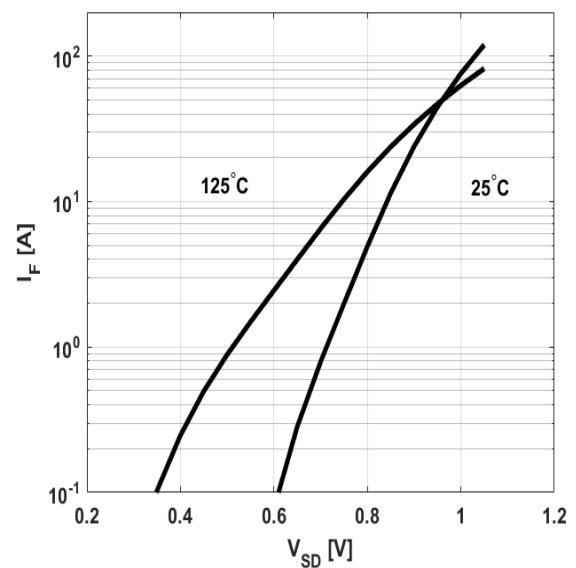
$$I_D = f(V_{GS}); V_{DS} = 20V$$

Figure 12: Typ. Gate Charge


$$V_{GS} = f(Q_{gate}), I_D = 24A \text{ pulsed}$$

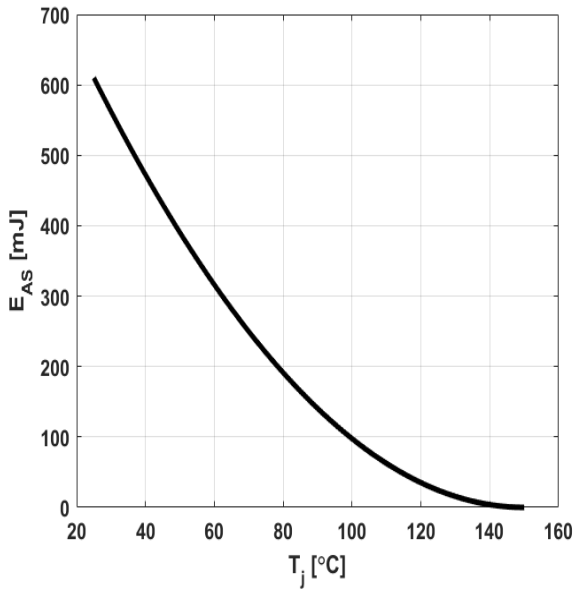
Figure 13: Drain-Source Breakdown Voltage


$$V_{BR(DSS)} = f(T_j); I_D = 1mA$$

Figure 14: Forward Characteristics of Reverse Diode


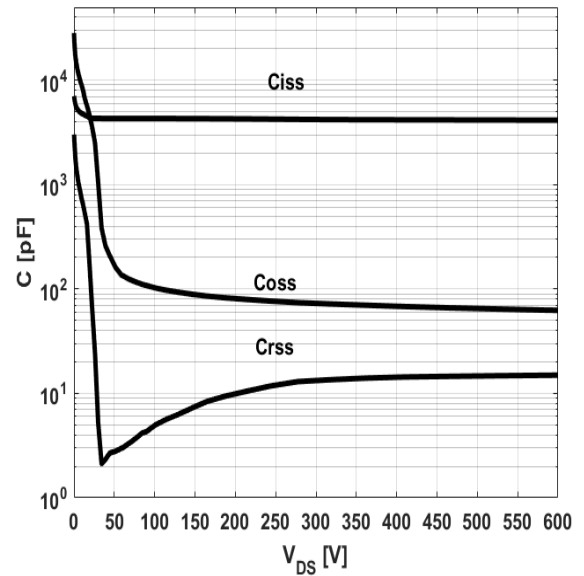
$$I_F = f(V_{SD}); \text{parameter: } T_j$$

Figure 15: Avalanche Energy



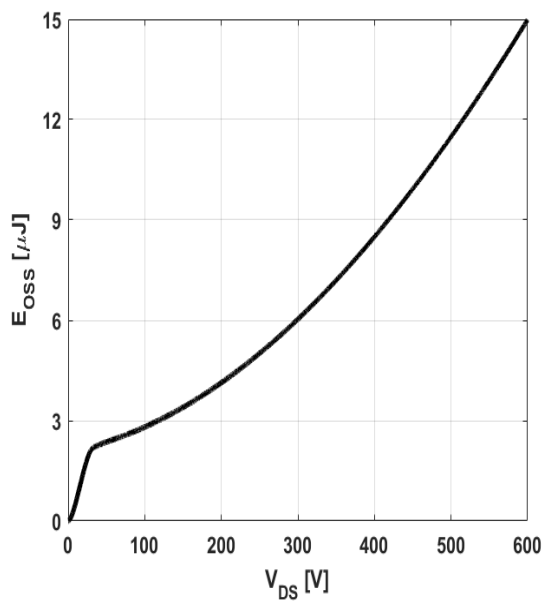
$E_{AS}=f(T_j)$; $I_D=4.8A$; $V_{DD}=60V$

Figure 16: Typ. Capacitances

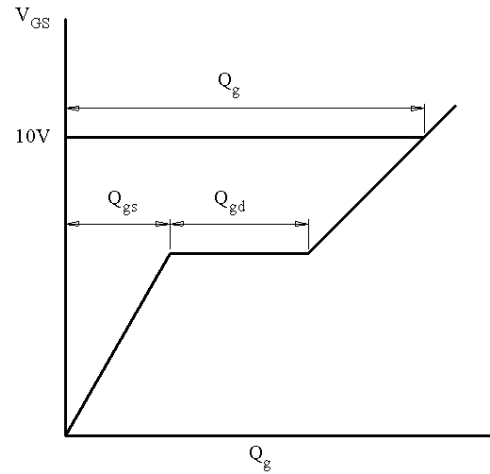
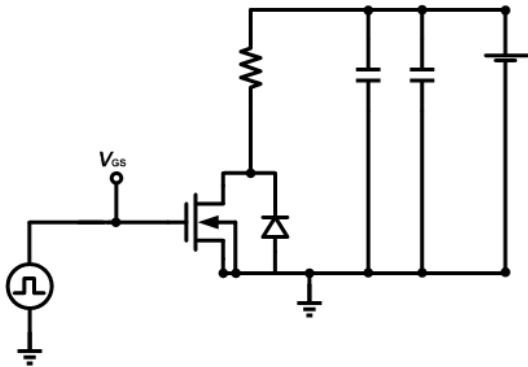
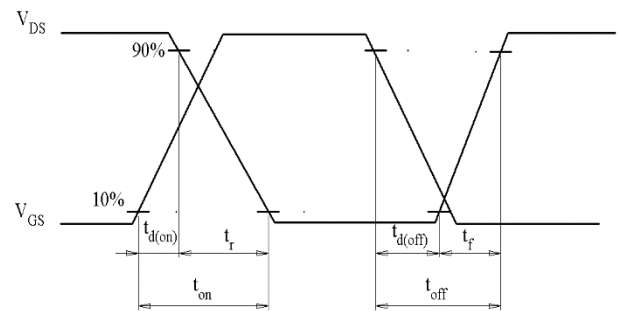
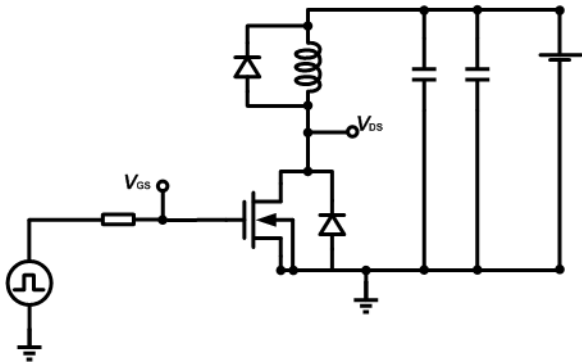
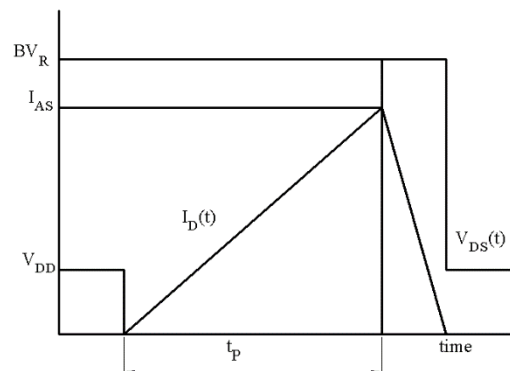
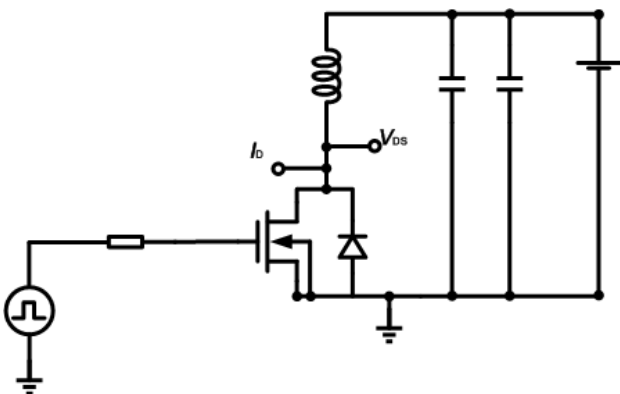


$C=f(V_{DS})$; $V_{GS}=0$; $f=1MHz$

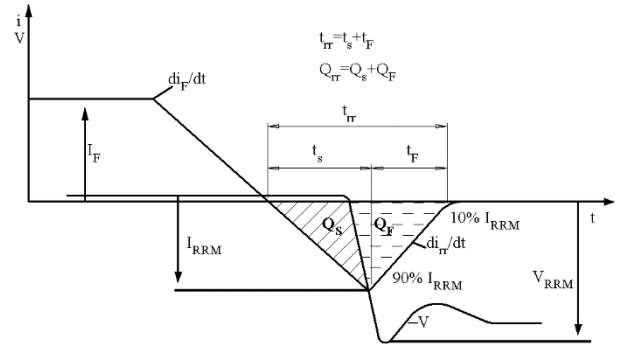
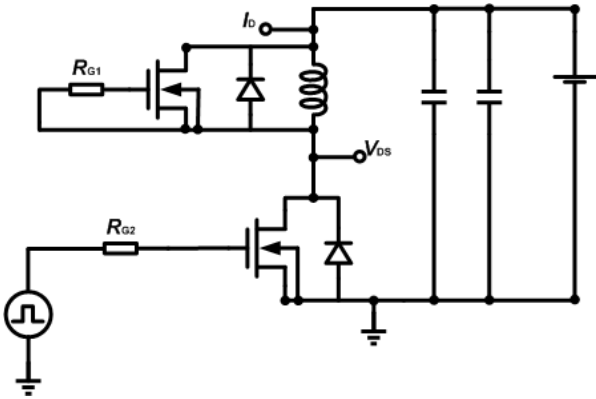
Figure 17: C_{OSS} Stored Energy



$E_{OSS}=f(V_{DS})$

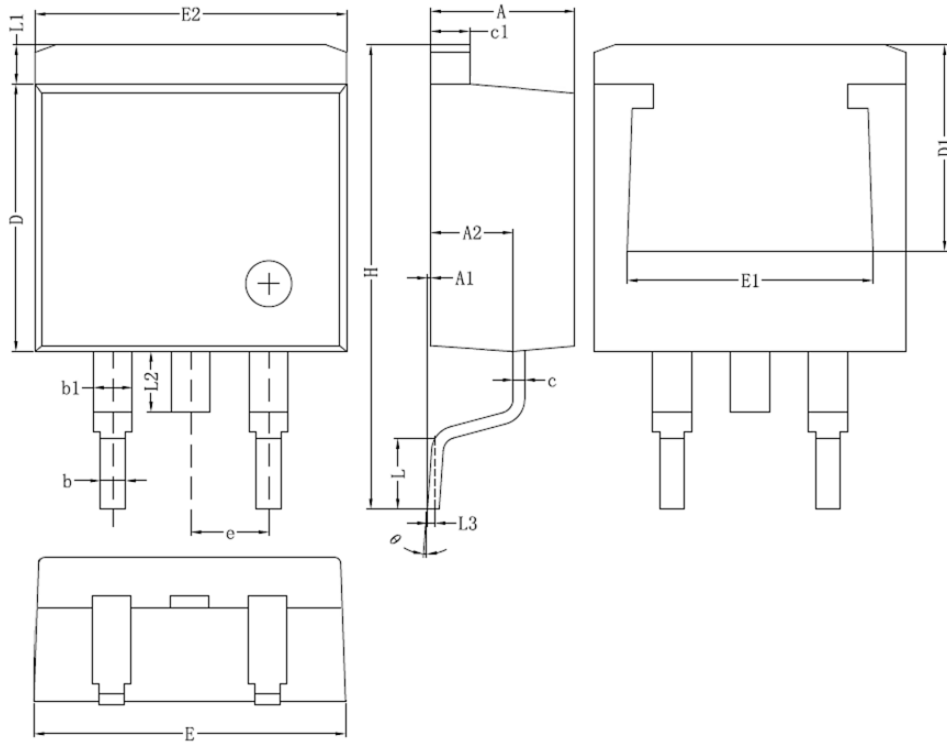
Test Circuits
1. Gate Charge Test Circuit & Waveform

2. Switch Time Test Circuit

3. Unclaimed Inductive Switching Test Circuit & Waveforms


4. Test Circuit and Waveform for Diode Characteristics

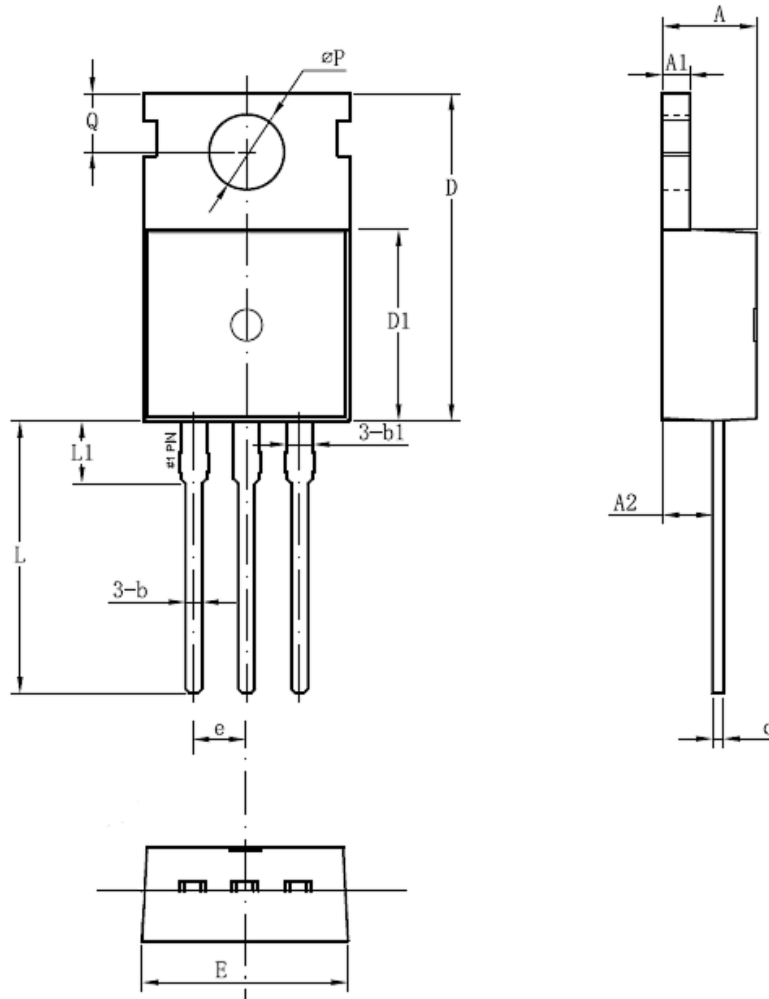


Mechanical Dimensions
TO-263-2

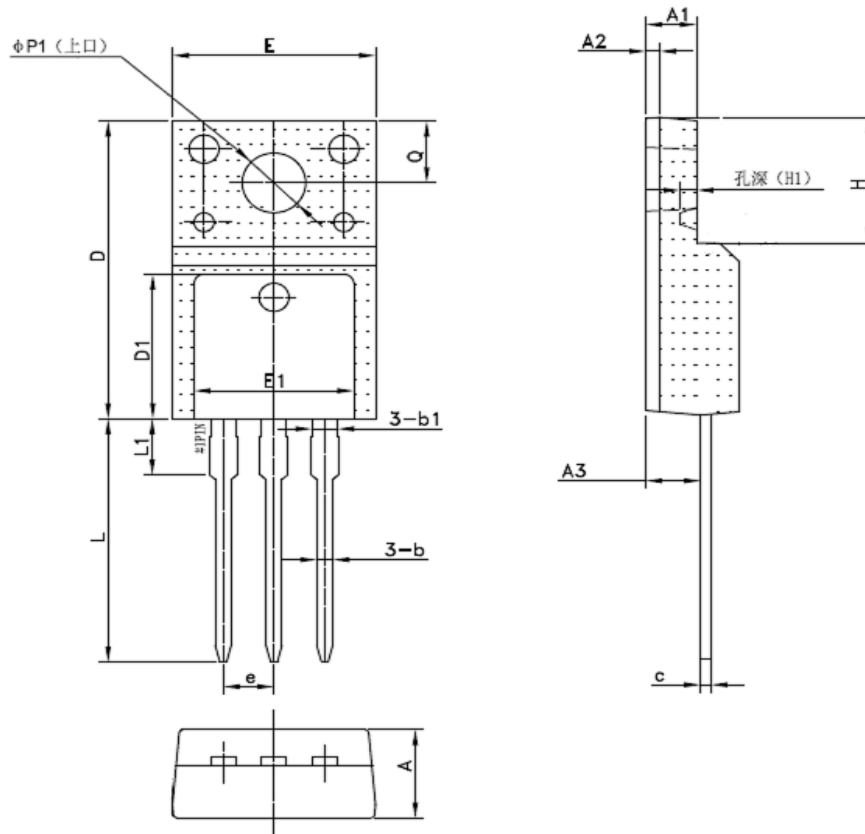
Unit: mm



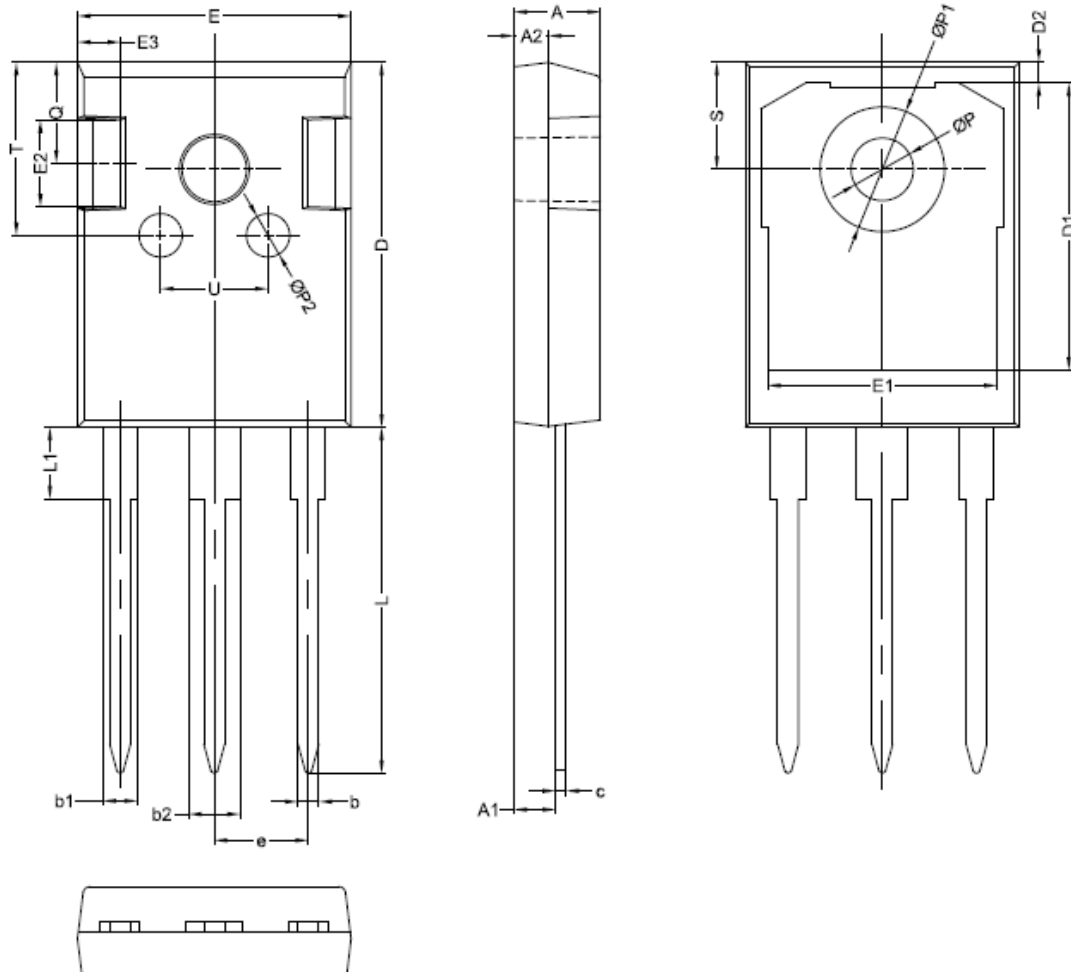
Symbol	Dimensions(mm)		
	Min.	Typ.	Max.
A	4.30	4.60	4.85
A1	0.00	0.10	0.25
A2	2.59	2.69	2.89
b	0.70	0.81	0.96
b1	-	1.27	-
c	0.36	0.40	0.61
c1	1.15	1.27	1.40
D	8.55	-	9.40
D1	6.40	-	-
E	9.80	10.10	10.31
E1	7.60	-	-
E2	9.80	10.00	10.20
e	2.54(BSC)		
H	14.70	15.20	16.00
L	2.00	2.30	2.84
L1	1.00	1.27	1.40
L2	-	-	2.20
L3	-	0.25	-
θ	0°	-	8°

Mechanical Dimensions (Continued)
TO-220C
Unit: mm


Symbol	Dimensions(mm)		
	Min.	Typ.	Max.
A	4.30	4.50	4.70
A1	1.20	1.30	1.40
A2	2.20	2.40	2.60
b	0.70	0.80	0.95
b1	-	1.27	-
c	0.40	0.50	0.65
D	15.20	15.70	16.20
D1	9.00	9.20	9.40
E	9.70	10.00	10.20
e	2.54(BSC)		
L	12.60	13.08	13.60
L1	-	3.00	-
ϕP	3.50	3.60	3.80
Q	2.60	2.80	3.00

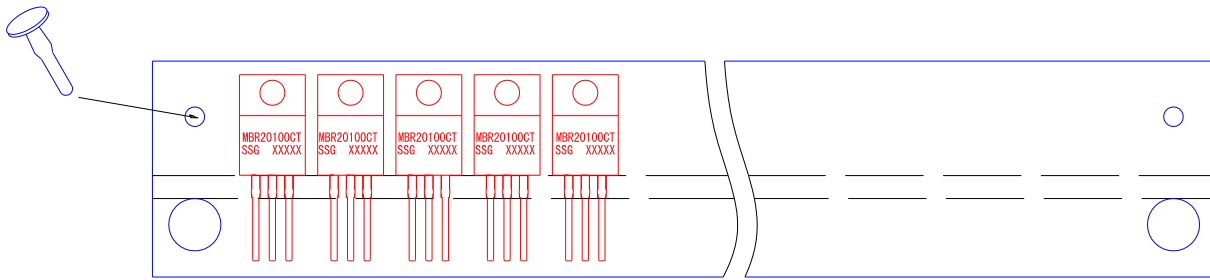
Mechanical Dimensions (Continued)
TO-220F
Unit: mm


Symbol	Dimensions(mm)		
	Min.	Typ.	Max.
A	4.30	4.70	4.90
A1	2.34	2.54	2.90
A2	-	0.70	-
A3	2.56	2.76	2.96
b	0.55	-	0.95
b1	-	1.28	-
c	0.42	0.50	0.70
D	14.70	-	16.07
D1	-	7.70	-
E	9.96	10.16	10.36
E1	-	8.00	-
e	2.54(BSC)		
H	-	6.70	-
(H1)	-	(0.81)	-
L	12.48	12.98	13.50
L1	-	2.93	-
ΦP1	-	3.18	-
Q	2.90	3.30	3.50

Mechanical Dimensions (Continued)
TO-247
Unit: mm


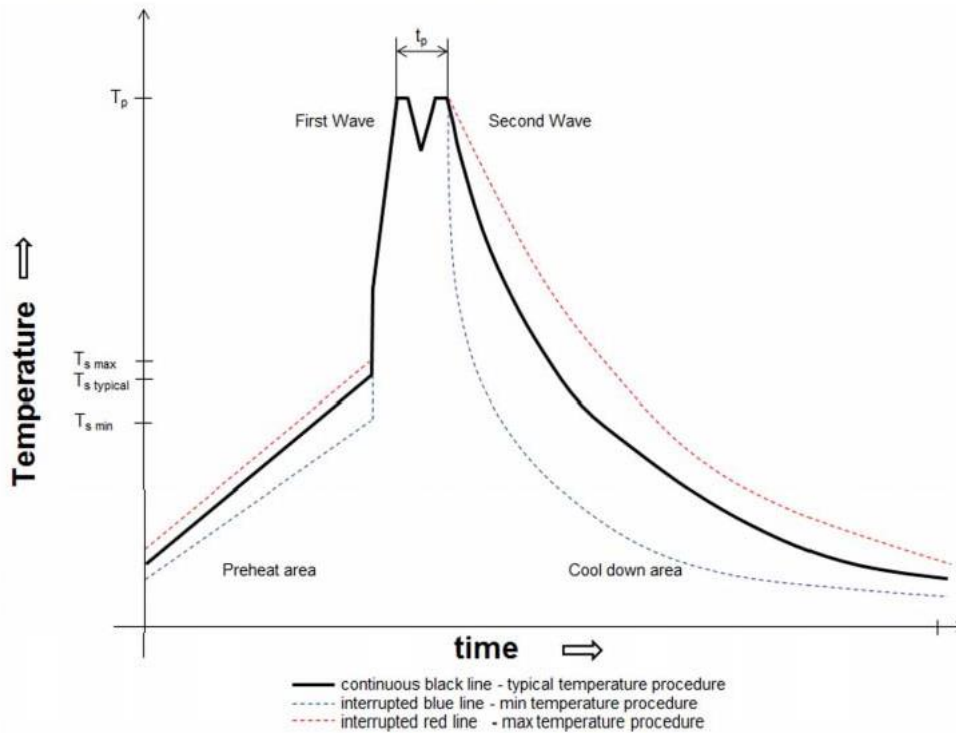
Symbol	Dimensions(mm)			Symbol	Dimensions(mm)		
	Min.	Typ.	Max.		Min.	Typ.	Max.
A	4.80	5.00	5.20	E2	-	5.00	-
A1	2.21	2.41	2.61	E3	-	2.50	-
A2	1.90	2.00	2.10	e	5.44(BSC)		
b	1.10	1.20	1.35	L	19.42	19.92	20.42
b1	-	2.00	-	L1	-	4.13	-
b2	-	3.00	-	P	3.50	3.60	3.70
c	0.55	0.60	0.75	P1	-	-	7.40
D	20.80	21.00	21.20	P2	-	2.50	-
D1	-	16.55	-	Q	-	5.80	-
D2	-	1.20	-	S	6.05	6.15	6.25
E	15.60	15.80	16.00	T	-	10.00	-
E1	-	13.30	-	U	-	6.20	-

Package Information



TO-247 type

Package Type	Packing Information
	pcs / Line
TO-247	30

Wave Solder Information
Classification Wave Soldering Profile:

Classification Wave Profile

Profile Feature	Pb-Free Assembly	Sn-Pb Assembly
Preheat - Temperature Min (T_{smin}) - Temperature Typical ($T_{stypical}$) - Temperature Max (T_{smax}) - Time (t_s) from (T_{smin} to T_{smax})	100°C 120°C 130°C 70 seconds	100°C 120°C 130°C 70 seconds
Δ preheat to max Temperature	150°C max.	150°C max.
Peak temperature (T_p)	250°C - 260°C	235°C - 260°C
Time of actual peak temperature (t_p)	max. 10 seconds max. 5 second each wave	max. 10 seconds max. 5 second each wave
Ramp-down rate - Min - Typical - Max	~ 2 K/s ~ 3.5 K/s ~ 5 K/s	~ 2 K/s ~ 3.5 K/s ~ 5 K/s
Time 25°C to 25°C	4 minutes	4 minutes

refer to EN 61760-1:2006



TM

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